



The Princeton Instruments/Acton PIXIS-XO: 2KB is a fully integrated, innovative imaging system that utilizes a CCD without AR coating for very low energy x-ray detection. With 2048 x 512, 13.5 μm pixels, 100% fill factor, deep thermoelectric cooling with air and low noise electronics this system is ideal for worry-free operation in research and OEM environments. The Conflat flange with high-vacuum-seal design, software-selectable gains and readout speeds make the camera well suited for ultra-high vacuum applications.

Applications: X-ray spectroscopy, EUV lithography, X-ray plasma diagnostics



Features	Benefits
Back illuminated CCD, no AR coating, direct detection technology	Provides very low x-ray flux imaging, high sensitivity and high spatial resolution
2 Mhz / 16-bit readout 100 kHz / 16 bit readout	High speed readout for rapid image acquisition Slow speed readout for high sensitivity with wide dynamic range, high signal-to-noise ratio (SNR) and excellent energy resolution
Software selectable gains for each digitization speed	Allows optimization of system performance for lowest noise to highest SNR
2048 x 512 image area, 13.5 x 13.5	Spectroscopy format designed for high-frame-rate imaging
Ultra low noise electronics	Best possible system performance
Flexible user selectable binning and readout	Total flexibility to optimize experiments and SNR
Deep thermoelectric air cooling	Maintenance-free operation without the need for a liquid circulator or an additional power supply
Conflat vacuum interface	Industry-standard, high-vacuum compatibility
TTL inout and output	External Trigger input with programmable polarity TTL output with exposure or readout monitor
"USB 2.0 interface" configuration	Seamless, plug-and-play connection to PC notebooks and desktops Easy OEM integration
WinView and PVCAM®	Offers powerful, easy-to-use set of Windows® GUI controls Automates data acquisition, analysis, and display
Linux® drivers and SITK™ plug-in for National Instruments' LabVIEW™	Extends system utility



PIXIS-XO: 2KB Specifications

CCD image sensor	Princeton Instruments elcusive; scientific grade 1; MPP; back-illuminated device; without AR coating			
CCD format	2048 x 512 imaging pixels 13.5 x 13.5 μm pixels 100% fill factor 27.6 x 6.9-mm imaging area (optically centered)			
	Minimum		Typical	
System read noise @ 100-kHz digitization @ 2-MHz digitization			3.5 e- rms 18 e- rms	5 e- rms 20 e- rms
	High Sensitivity	High Capacity	High Sensitivity	High Capacity
Spectrometric well capacity	150 ke-	600 ke-	250 ke-	800 Me-
Dark current @ -75°C operation	0.003 e-/p/s			0.008 e-/p/s
Deepest cooling temperature*	-70°C		-75°C	
Thermostating precision	$\pm 0.05^\circ\text{C}$ across entire temperature range			
Software-selectable gains (e-/count)	1, 2, 4 (high sensitivity mode) 4, 8, 16 (high capacity mode)			
Dynamic range	16 bits			
Nonlinearity	<2% @100 kHz, <2% @ 2 MHz			
Vertical shift rate	15.2 μsec per row			
Spectral rates* @ 100 kHz digitization @ 2 MHz digitization	35 Hz 90Hz			
Operating environment	+5 to +30°C non-condensing			

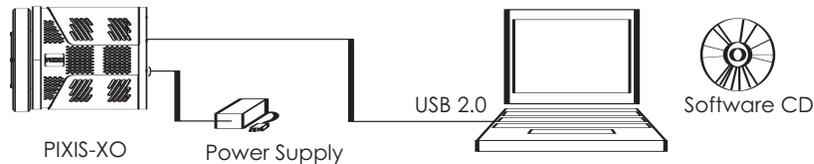
Notes: All specifications subject to change.

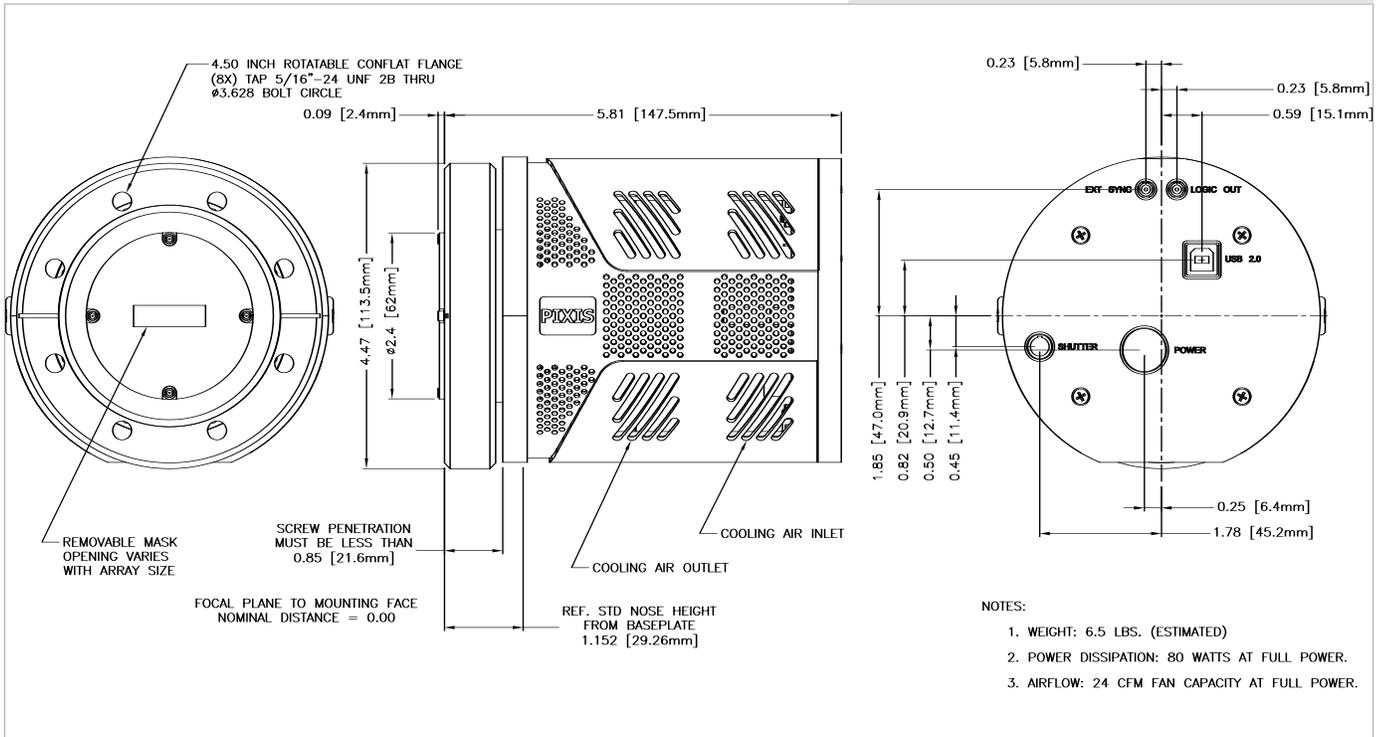
* Spectral rates measured with all rows vertically binned.

* The minimum temperature attainable is dependent on the vacuum condition (can be lowered with lower vacuum).

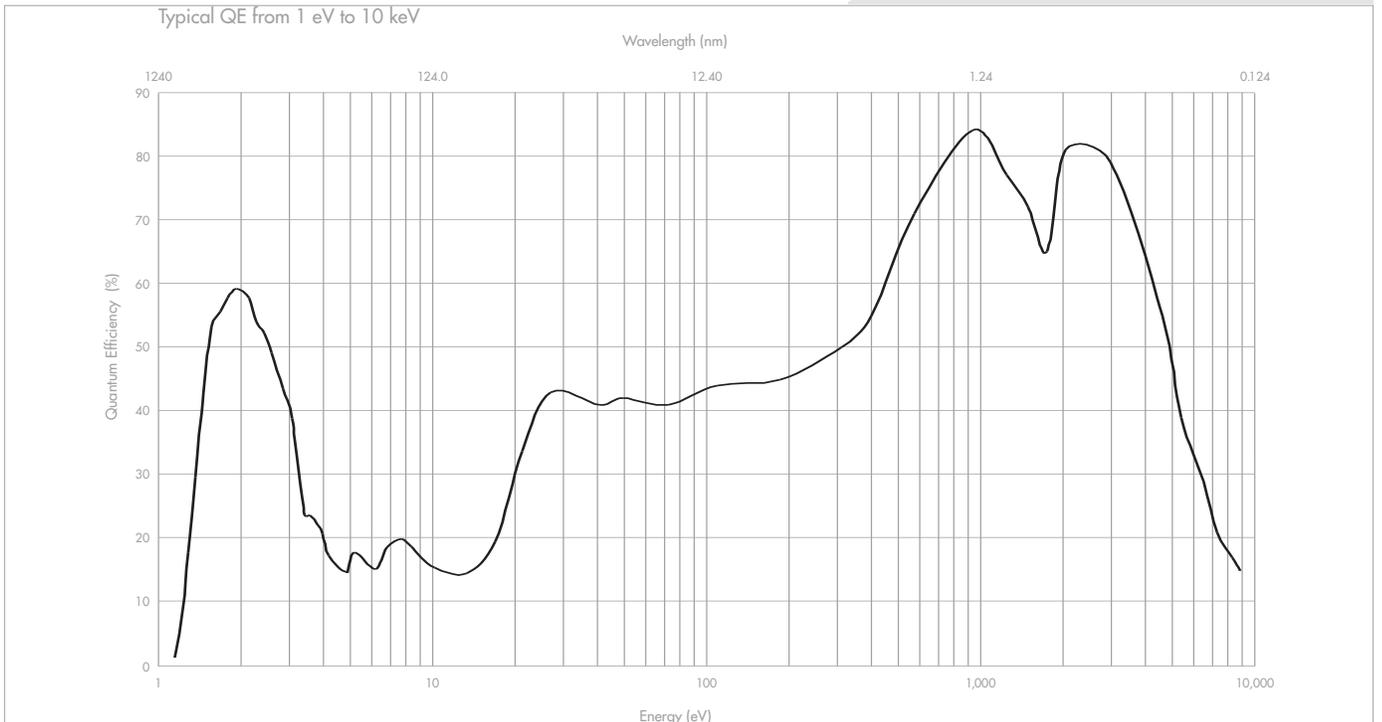
Readout Rates

Binning	@ 2 MHz	@ 100 kHz
1 x 1	560 msec	9.1 sec
2 x 2	233 msec	2.5 sec
2048 x 1	11.1 msec	27.8 msec





Quantum Efficiency Curve



Princeton Instruments



www.piacton.com

email: moreinfo@piacton.com

USA +1.609.587.9797 | Benelux +31 (347) 324989

France +33 (1) 60.86.03.65 | Germany +49 (0) 89.660.779.3

Japan +81.3.5639.2741 | UK +44 (0) 28.383101.71